

July, 2007

FGA25N120ANTD/FGA25N120ANTD_F109 1200V NPT Trench IGBT

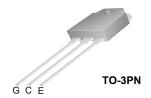
Features

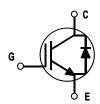
- · NPT Trench Technology, Positive temperature coefficient
- Low saturation voltage: V_{CE(sat), typ} = 2.0V
 Q I_C = 25A and T_C = 25°C
- Low switching loss: $E_{\rm off,\ typ}$ = 0.96mJ @ I_C = 25A and T_C = 25°C
- · Extremely enhanced avalanche capability

Description

Using Fairchild's proprietary trench design and advanced NPT technology, the 1200V NPT IGBT offers superior conduction and switching performances, high avalanche ruggedness and easy parallel operation.

This device is well suited for the resonant or soft switching application such as induction heating, microwave oven, etc.





Absolute Maximum Ratings

Symbol	Description		FGA25N120ANTD	Units
V _{CES}	Collector-Emitter Voltage		1200	V
V _{GES}	Gate-Emitter Voltage		± 20	V
I _C	Collector Current	@ T _C = 25°C	50	Α
	Collector Current	@ T _C = 100°C	25	Α
I _{CM}	Pulsed Collector Current (Note 1)		90	Α
I _F	Diode Continuous Forward Current @ T _C = 100°C		25	Α
I _{FM}	Diode Maximum Forward Current		150	Α
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	312	W
	Maximum Power Dissipation	@ T _C = 100°C	125	W
T _J	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case for IGBT		0.4	°C/W	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case for Diode		2.0	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W	

Rev. B

Package Marking and Ordering Information

Device MarkingDevicePackageReel SizeTape WidthQuantityFGA25N120ANTDFGA25N120ANTDTO-3P----30

Electrical Characteristics of the IGBT $T_C = 25^{\circ}C$ unless otherwise noted

Symbo	ol Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Off Chara	acteristics						
I_{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			3	mA	
I_{GES}	G-E Leakage Current	V					

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Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

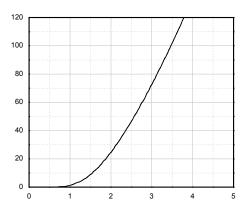
Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
V_{FM}	Diode Forward Voltage	I _F = 25A	T _C = 25°C		2.0	3.0	V
			T _C = 125°C		2.1		
t _{rr}	Diode Reverse Recovery Time	I _F = 25A	T _C = 25°C		235	350	ns
		dI/dt = 200 A/μs	T _C = 125°C		300		
I _{rr}	Diode Peak Reverse Recovery Current		T _C = 25°C		27	40	Α
			T _C = 125°C		31		
Q _{rr}	Diode Reverse Recovery Charge		T _C = 25°C		3130	4700	nC
			T _C = 125°C		4650		

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Typical Performance Characteristics

Figure 1. Typical Output Characteristics

Figure 2. Typical Saturation Voltage



Typical Performance Characteristics (Continued)

Figure 7. Capacitance Characteristics

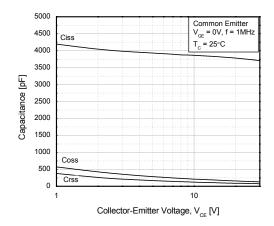


Figure 9. Turn-Off Characteristics vs. Gate Resistance

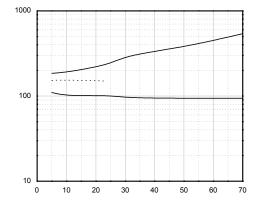


Figure 8. Turn-On Characteristics vs. Gate Resistance

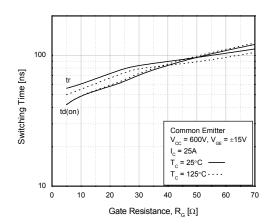
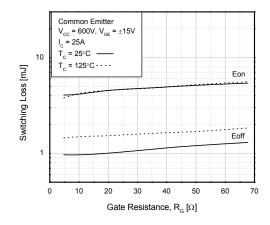


Figure 10. Switching Loss vs. Gate Resistance



5 www.fairchildsemi.com

Typical Performance Characteristics (Continued)

Figure 13. Switching Loss vs. Collector Current

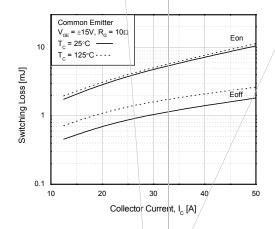


Figure 14. Gate Charge Characteristics

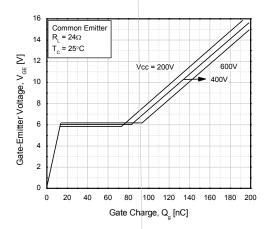


Figure 15. SOA Characteristics

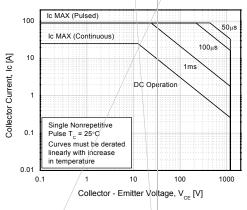


Figure 16. Turn-Off SOA

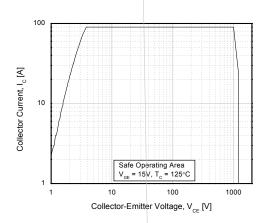


Figure 17. Transient Thermal Impedance of IGBT

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Typical Performance Characteristics (Continued)

Figure 18. Forward Characteristics

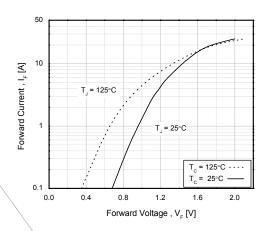
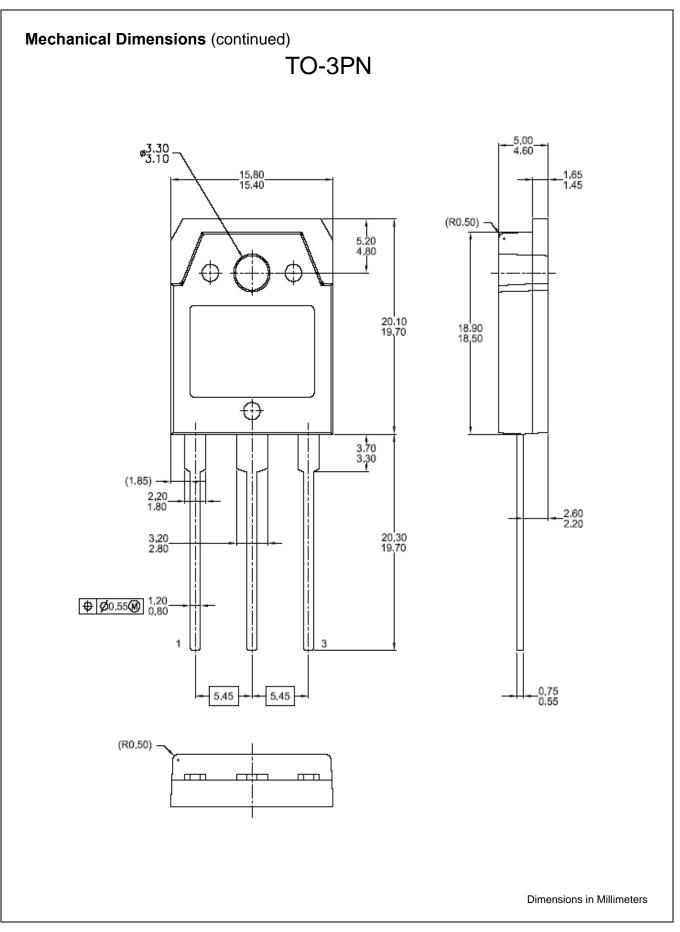


Figure 19. Reverse Recovery Current

7 www.fairchildsemi.com

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